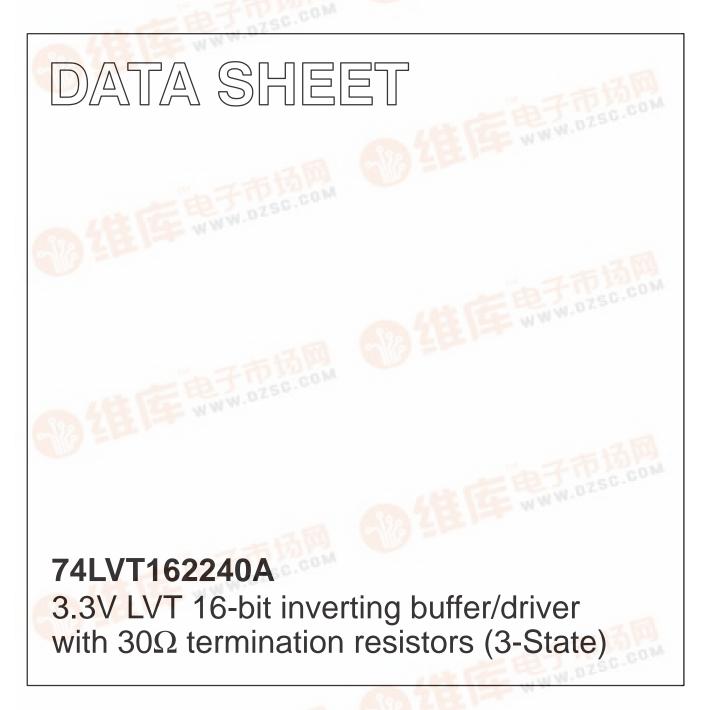
## INTEGRATED CIRCUITSPOBT样工厂, 24小时加急



Product specification Supersedes data of 1995 Aug 22 IC23 Data Handbook 1998 Feb 19







## 3.3V 16-bit inverting buffer/driver with 30 $\Omega$ termination resistors (3-State)

## 74LVT162240A

#### **FEATURES**

- 16-bit bus interface
- 3-State buffers
- Output capability: +12mA/-12mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Outputs include series resistance of 30Ω making external termination resistors unnecessary
- Power-up 3-State
- No bus current loading when output is tied to 5V bus
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model
- Same part as 74LVT16240A-1

### QUICK REFERENCE DATA

#### DESCRIPTION

The 74LVT162240A is a high-performance BiCMOS product designed for  $V_{CC}$  operation at 3.3V.

This device is an inverting 16-bit buffer that is ideal for driving bus lines. The device features four Output Enables  $(1\overline{OE}, 2\overline{OE}, 3\overline{OE}, 4\overline{OE})$ , each controlling four of the 3-State outputs.

The 74LVT162240A is designed with  $30\Omega$  series resistance in both the pull-up and pull-down output structures. This design reduces line noise in applications such as memory address drivers, clock drivers, and bus receivers/transmitters.

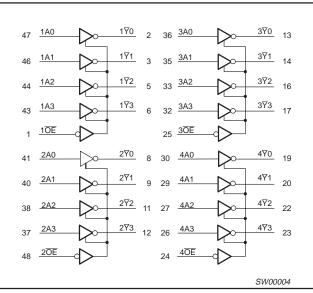
The 74LVT162240A is the same as the 74LVT16240A-1. The part number has been changed to reflect industry standards.

SYMBOL	PARAMETER	CONDITIONS T <sub>amb</sub> = 25°C	TYPICAL	UNIT
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay $nAx$ to $n\overline{Y}x$	C <sub>L</sub> = 50pF; V <sub>CC</sub> = 3.3V	2.6	ns
C <sub>IN</sub>	Input capacitance nOE	V <sub>I</sub> = 0V or 3.0V	3	pF
C <sub>OUT</sub>	Output capacitance	V <sub>O</sub> = 0V or 3.0V	9	pF
I <sub>CCZ</sub>	Total supply current	Outputs disabled; $V_{CC} = 3.6V$	70	μΑ

#### **ORDERING INFORMATION**

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
48-Pin Plastic SSOP Type III	–40°C to +85°C	74LVT162240A DL	VT162240A DL	SOT370-1
48-Pin Plastic TSSOP Type II	-40°C to +85°C	74LVT162240A DGG	VT162240A DGG	SOT362-1

### LOGIC SYMBOL



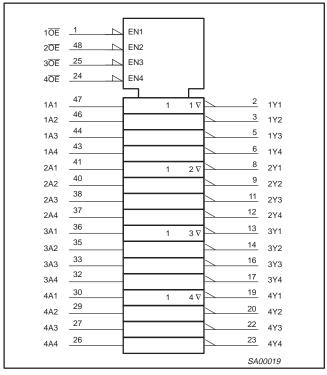
### **PIN DESCRIPTION**

PIN NUMBER	SYMBOL	NAME AND FUNCTION	
47, 46, 44, 43, 41, 40, 38, 37, 36, 35, 33, 32, 30, 29, 27, 26	1A0 - 1A3 2A0 - 2A3 3A0 - 3A3 4A0 - 4A3	Data inputs	
2, 3, 5, 6, 8, 9, 11, 12, 13, 14, 16, 17, 19, 20, 22, 23	170 - 173 270 - 273 370 - 373 470 - 473	Data outputs	
1, 48 25, 24	1 <u>0E,</u> 2 <u>0E,</u> 30E, 40E	Output enables	
4, 10, 15, 21, 28, 34, 39, 45	GND	Ground (0V)	
7, 18, 31, 42	V <sub>CC</sub>	Positive supply voltage	

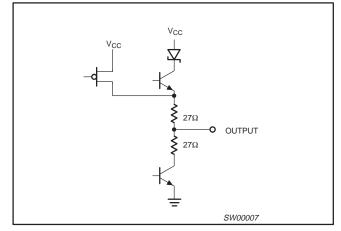
## 3.3V 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

## 74LVT162240A

### LOGIC SYMBOL (IEEE/IEC)



### SCHEMATIC OF EACH OUTPUT



#### **PIN CONFIGURATION**

		1	
1 <del>0E</del>	1	48	2 <mark>0E</mark>
1₹0	2	47	1A0
1₹1	3	46	1A1
GND	4	45	GND
172	5	44	1A2
1\73	6	43	1A3
VCC	7	42	VCC
2叉0	8	41	2A0
2₹1	9	40	2A1
GND	10	39	GND
272	11	38	2A2
273	12	37	2A3
370	13	36	3A0
3∀1	14	35	3A1
GND	15	34	GND
3∀2	16	33	3A2
3₹4	17	32	3A3
VCC	18	31	Vcc
4∀0	19	30	4A0
4∀1	20	29	4A1
GND	21	28	GND
4 <u>¥</u> 2	22	27	4A2
4∀3	23	26	4A3
4 <del>0E</del>	24	25	3 <del>0E</del>
	CI4/00		
	SWOO	000	

#### **FUNCTION TABLE**

INPU	OUTPUTS	
nOE	nAx	n∀x
L	L	Н
L	Н	L
Н	Х	Z

H = High voltage level

L = Low voltage level

X = Don't care

Z = High Impedance "off" state

## 3.3V 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

## 74LVT162240A

### ABSOLUTE MAXIMUM RATINGS<sup>1, 2</sup>

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V <sub>CC</sub>	DC supply voltage		-0.5 to +4.6	V
I <sub>IK</sub>	DC input diode current	V <sub>1</sub> < 0	-50	mA
VI	DC input voltage <sup>3</sup>		-0.5 to +7.0	V
Ι <sub>ΟΚ</sub>	DC output diode current	V <sub>O</sub> < 0	-50	mA
V <sub>OUT</sub>	DC output voltage <sup>3</sup>	Output in Off or High state	-0.5 to +7.0	V
lout		Output in Low state	128	
	DC output current	Output in High state	-64	- mA
T <sub>stg</sub>	Storage temperature range		-65 to +150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

2. The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

3.

### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER	LIM	UNIT	
STWBOL	FARAIVIETER	MIN	MAX	UNIT
V <sub>CC</sub>	DC supply voltage	2.7	3.6	V
VI	Input voltage	0	5.5	V
V <sub>IH</sub>	High-level input voltage	2.0		V
V <sub>IL</sub>	Input voltage		0.8	V
I <sub>OH</sub>	High-level output current		-12	mA
I <sub>OL</sub>	Low-level output current		12	mA
Δt/Δv	Input transition rise or fall rate; Outputs enabled		10	ns/V
T <sub>amb</sub>	Operating free-air temperature range	-40	+85	°C

## 3.3V 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

## 74LVT162240A

		TEST CONDITIONS		LIMITS			
SYMBOL	PARAMETER			Temp = -40°C to +85°C			UNIT
				MIN	TYP <sup>1</sup>	МАХ	
V <sub>IK</sub>	Input clamp voltage	V <sub>CC</sub> = 2.7V; I <sub>IK</sub> = -18mA			-0.85	1.2	V
V <sub>OH</sub>	High-level output voltage	V <sub>CC</sub> = 3.0V; I <sub>OH</sub> = -12mA		2.0			V
V <sub>OL</sub>	Low-level output voltage	V <sub>CC</sub> = 3.0V; I <sub>OL</sub> = 12mA				0.8	V
		$V_{CC} = 3.6$ V; $V_{I} = V_{CC}$ or GND	Control pins		0.1	±1	
		V <sub>CC</sub> = 0 or 3.6V; V <sub>I</sub> = 5.5V			0.4	10	
łı	Input leakage current	$V_{CC} = 3.6V; V_{I} = V_{CC}$			0.1	1	μA
		$V_{CC} = 3.6V; V_{I} = 0$	Data pins <sup>4</sup>		-0.4	-5	
I <sub>OFF</sub>	Output off current	$V_{CC} = 0V; V_1 \text{ or } V_0 = 0 \text{ to } 4.5V$			0.1	±100	μA
		$V_{CC} = 3V; V_{I} = 0.8V$		75	135		
I <sub>HOLD</sub>	Bus Hold current A outputs <sup>6</sup>	$V_{CC} = 3V; V_I = 2.0V$		-75	-135		μΑ
		$V_{CC} = 0V$ to 3.6V; $V_{CC} = 3.6V$		±500			
$I_{EX}$	Current into an output in the High state when $V_O > V_{CC}$	V <sub>O</sub> = 5.5V; V <sub>CC</sub> = 3.0V			50	125	μA
I <sub>PU/PD</sub>	Power up/down 3-State output current <sup>3</sup>	$V_{CC} \le 1.2V$ ; $V_O = 0.5V$ to $V_{CC}$ ; $V_I = GND$ or $V_{CC}$ OE/OE = Don't care			1	±100	μΑ
I <sub>OZH</sub>	3-State output High current	$V_{CC}$ = 3.6V; $V_{O}$ = 3.0V; $V_{I}$ = $V_{IL}$ or $V_{IH}$			0.5	5	μΑ
I <sub>OZL</sub>	3-State output Low current	$V_{CC}$ = 3.6V; $V_{O}$ = 0.5V; $V_{I}$ = $V_{IL}$ or $V_{IH}$			0.5	-5	μΑ
I <sub>CCH</sub>		$V_{CC} = 3.6V$ ; Outputs High, $V_I = GND$ or $V_{CC} = 0.000$	/ <sub>CC,</sub> I <sub>O =</sub> 0		0.07	0.12	
I <sub>CCL</sub>	Quiescent supply current	$V_{CC}$ = 3.6V; Outputs Low, $V_{I}$ = GND or $V_{CC}$ , $I_{O}$ = 0			4.0	6	mA
I <sub>CCZ</sub>	1	$V_{CC}$ = 3.6V; Outputs Disabled; V <sub>I</sub> = GND or V <sub>CC</sub> , I <sub>O = 0</sub> <sup>5</sup>			0.07	0.12	
$\Delta I_{CC}$	Additional supply current per input pin <sup>2</sup>	$V_{CC}$ = 3V to 3.6V; One input at $V_{CC}$ -0.6V Other inputs at $V_{CC}$ or GND	7		0.1	0.20	mA

## **DC ELECTRICAL CHARACTERISTICS**

NOTES:

All typical values are at V<sub>CC</sub> = 3.3V and T<sub>amb</sub> = 25°C.
This is the increase in supply current for each input at the specified voltage level other than V<sub>CC</sub> or GND
This parameter is valid for any V<sub>CC</sub> between 0V and 1.2V with a transition time of up to 10msec. From V<sub>CC</sub> = 1.2V to V<sub>CC</sub> = 3.3V ± 0.3V a transition time of 100µsec is permitted. This parameter is valid for T<sub>amb</sub> = 25°C only.

4. Unused pins at V<sub>CC</sub> or GND.

5.  $I_{CCZ}$  is measured with outputs pulled to  $V_{CC}$  or GND. 6. This is the bus hold overdrive current required to force the input to the opposite logic state.

## **AC CHARACTERISTICS**

GND = 0V;  $t_R = t_F = 2.5ns$ ;  $C_L = 50pF$ ;  $R_L = 500\Omega$ ;  $T_{amb} = -40^{\circ}C$  to +85°C.

			LIMITS				
SYMBOL	PARAMETER	WAVEFORM	V <sub>CC</sub> = 3.3V ±0.3V			V <sub>CC</sub> = 2.7V	UNIT
			MIN	TYP <sup>1</sup>	MAX	MAX	
t <sub>PLH</sub> t <sub>PHL</sub>	Propagation delay nAx to nYx	1	0.5 0.5	2.6 2.6	4.2 4.2	5.0 5.0	ns
t <sub>PZH</sub> t <sub>PZL</sub>	Output enable time to High and Low level	2	1.0 1.0	3.3 3.0	5.5 5.0	6.5 5.5	ns
t <sub>PHZ</sub> t <sub>PLZ</sub>	Output disable time from High and Low Level	2	1.0 1.0	3.5 3.2	5.0 4.5	5.5 4.5	ns

NOTE:

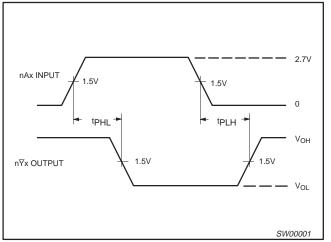
1. All typical values are at V\_{CC} = 3.3V and T\_{amb} = 25^{\circ}C.

## 3.3V 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

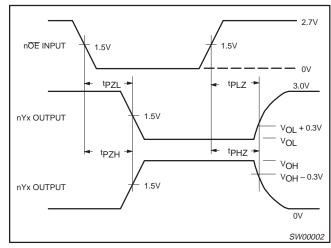
## 74LVT162240A

#### AC WAVEFORMS

 $V_{M}$  = 1.5V,  $V_{IN}$  = GND to 2.7V



Waveform 1. Input (nAx) to Output (nYx) Propagation Delays



Waveform 2. 3-State Output Enable and Disable Times

#### 6V VCC tw AMP (V) 90% 90% • OPEN NEGATIVE ٧M ٧N PULSE GND 10% 10% VIN VOUT RL 0V PULSE D.U.T. tTHL (tF) tTLH (tR) GENERATOR ttlh (tr) Rт tTHL (tF) Rı AMP (V) 90% 90% POSITIVE ٧M ٧м PULSE **Test Circuit for 3-State Outputs** 10% 10% 0V tw SWITCH POSITION V<sub>M</sub> = 1.5V SWITCH TEST Input Pulse Definition GND t<sub>PHZ</sub>/t<sub>PZH</sub> 6V t<sub>PLZ</sub>/t<sub>PZL</sub> t<sub>PLH</sub>/t<sub>PHL</sub> open **INPUT PULSE REQUIREMENTS** DEFINITIONS FAMILY R<sub>I</sub> = Load resistor; see AC CHARACTERISTICS for value. Amplitude Rep. Rate t<sub>R</sub> tw tF C<sub>L</sub> = Load capacitance includes jig and probe capacitance; see AC CHARACTERISTICS for value. 500ns 74LVT16 2.7V ≤10MHz ≤2.5ns ≤2.5ns $R_T =$ Termination resistance should be equal to ZOUT of

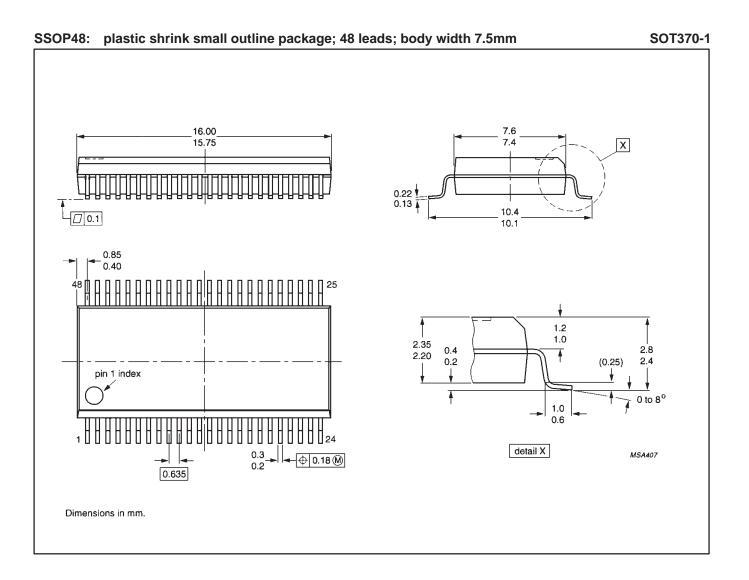
#### TEST CIRCUIT AND WAVEFORMS

pulse generators.

<u>SW0</u>0003

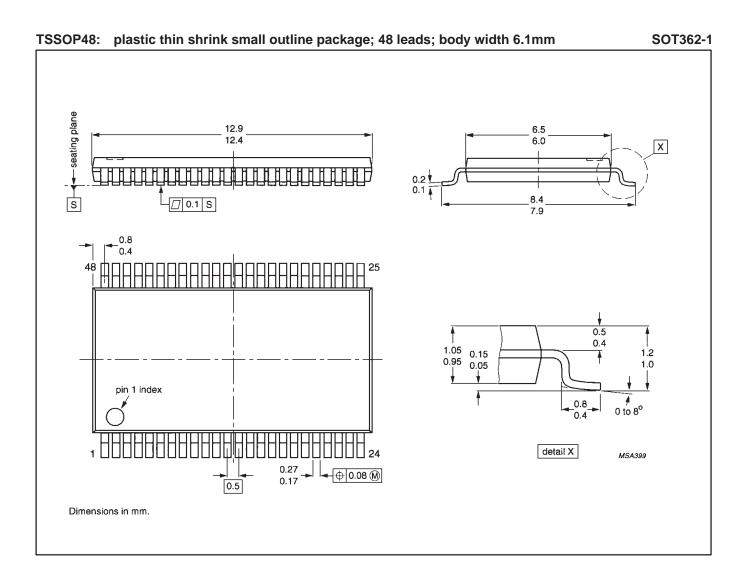
## 3.3V LVT 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

## 74LVT162240A



## 3.3V LVT 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

## 74LVT162240A



# 3.3V LVT 16-bit inverting buffer/driver with 30 $\!\Omega$ termination resistors (3-State)

74LVT162240A

NOTES

## 3.3V LVT 16-bit inverting buffer/driver with $30\Omega$ termination resistors (3-State)

## 74LVT162240A

#### Data sheet status

Data sheet status	Product status	Definition <sup>[1]</sup>
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
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